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CUSTOMER NO.: 27623 Sheet <u>2</u> of <u>2</u>. FORM PTO-1449 Docket Number (Optional) **Application Number** 335.7735USU Not Yet Assigned Applicant INFORMATION DISCLOSURE CITATION IN AN APPLICATION Binod et al. Filing Date **Group Art Unit** (Use several sheets if necessary) October 31, 2003 Not Yet Assigned **U. S. PATENT DOCUMENTS** EXAMINER **FILING DATE IF** INITIAL DOCUMENT DATE NAME **CLASS** SUBCLASS **APPROPRIATE** NUMBER FOREIGN PATENT DOCUMENTS **Translation** DOCUMENT DATE COUNTRY CLASS **SUBCLASS** YES NUMBER OTHER DOCUMENTS (including Author, Title, Date, Pertinent Pages, Etc.) Wu et al., "Incorporation of polyhedral oligosilsesquioxane in chemically amplified resists to improve their reative ion etching resistance", J. Vac. Sci. Techno. B 19 (3), May/June 2001, Pgs. 851-855. Gonsalves et al., "Organic-Inorganic Nanocomposites: Unique Resists for Nanolithography", Adv. Mater. 2001, 13, No> 10, May 17, 2001, Pgs. 703-714.

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